

<b>Notice of References Cited</b>	Application/Control No. 10/663,024		Applicant(s)/Patent Under Reexamination AMINE ET AL.	
	Examiner Alix Elizabeth Echelmeyer		Art Unit 1745	Page 1 of 1

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	N	WO 02/28500 A1	04-2002	WIPO	WIETELMANN et al.	
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